

Notice of References Cited	Application/Control No. 10/685,680	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Kenneth J Whittington	Art Unit 2862	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0048112 A1	04-2002	Chu et al.	360/75
	B	US-2002/0063559 A1	05-2002	Richter, Hans J.	324/212
	C	US-2002/0048108 A1	04-2002	Chu et al.	360/53
	D	US-6,084,739 A	07-2000	Assouad, Nicolas C.	360/77.08
	E	US-4,876,685	10-1989	Rich, Marc A.	714/723
	F	US-5,563,746 A	10-1996	Bliss, William G.	360/53
	G	US-2003/0206359 A1	11-2003	Hashimoto, Akihiro	360/53
	H	US-6,466,895 B1	10-2002	Harvey et al.	702/181
	I	US-2004/0129877 A1	07-2004	Mankos et al.	250/307
	J	US-6,366,085 B1	04-2002	Yeshurun et al.	324/263
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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